

**Notice of References Cited**Application/Control No.  
**09/516,078**Applicant(s)/Patent Under Reexam  
**Hertelendy et al**

Examiner

**Portner**

Art Unit

**1645**

Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,783,194	7/1998	Brown	424	211.1
B	6,585,980	7/2003	Chan et al	424	234.1
C	4,221,705	9/1980	Kondo	260	112.5 R
D	4,360,593	11/1982	Konishi et al	435	70
E	6,218,147	4/2001	Lingwood	435	69.3
F	5,853,767	12/1998	Melman	424	659
G	6,420,425	7/2002	Melman	514	557
H	6,572,863	6/2003	Rovinski et al	424	208.1
I	6,136,336	10/2000	Tanaka et al	424	434
J	6,383,471	5/2002	Chen et al	424	45
K	20,020,034,498	3/2002	Smith et al	424	93.6
L					
M					

**FOREIGN PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
N	99/31,250	6/1999	WO	Rovinski et al	C12N	15/49
O						
P						
Q						
R						
S						
T						

**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	
V	
W	
X	

\* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.